

SW Test Workshop

Semiconductor Wafer Test Workshop

June 7 - 10, 2015 | San Diego, California

Welcome to the 25th Annual SW Test Workshop



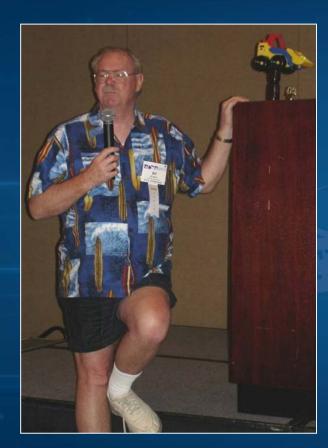
Jerry Broz, Ph.D.
SW Test General Chair

Twenty-Five Years of Probe Technology

Many thanks to all of the 7500+ attendees from around the world!



Southwest Test Workshop



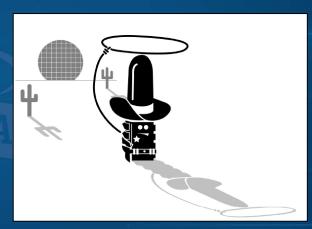
William R. Mann
Founder of SW Test Workshop
SW Test Lifetime Achievement Recipient
Senior Member IEEE

- 1990: Bill Man (at Rockwell) organized a small user's group that focused on wafer test issues and included key suppliers.
- 1991: Recognized the need for a dedicated forum on all aspects of microelectronic wafer probe testing that deals with "real world" problems and solutions
 - 40 technologists attended the first "official" workshop
 - Unique "presentation only" format (i.e., no technical manuscript) and all presentations were made available in the public domain
 - Relaxed atmosphere that balanced a technical program (~50%) with open discussions, social activities, and networking (~50%)

Southwest Test Workshop

- 1992 onward: SWTW grew to become a premier wafer test and probe technology workshop.
 - Over 400 technologists from around the world attend each year (with as many as 675 attendees)
 - Technical program with 9-sessions and 29presentations that often include new technologies and product introductions
- 2004: SW Test "table top" EXPO was added to the workshop program
 - SW Test EXPO focused exclusively on probe-related products and services.
 - SW Test EXPO provided even more opportunities for networking and socializing.
 - SW Test EXPO now has full-sized booth an sells out!







Semiconductor Wafer Test Workshop (now the SW Test Workshop)

- 2006 to present: Jerry Broz, Ph.D., becomes the General Chair of SW Test Workshop
 - Established the William R. Mann Student Travel Grant
 - Moved away from Computer Society to CPMT

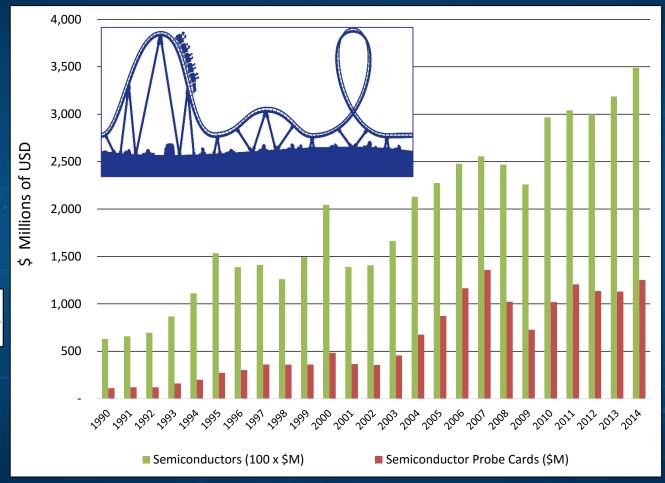




- 2010 to present: SW Test Workshop moves to RBI
 - High quality technical content and great networking
 - International attendance with more opportunities for socializing as well as problem solving.



It's Been Quite a Ride!



IC = \$348.8B PC = \$1.25B





Thanks to John West, VLSI Research

IC = \$63.9B PC = \$110M





Semi Industry Overview

Top 10 Worldwide Semiconductor Sales Leaders* (\$B)

Rank	1990		1995		2000		2006		2012		1Q14	
1	NEC	4.8	Intel	13.6	Intel	29.7	Intel	31.6	Intel	49.1	Intel	11.7
2	Toshiba	4.8	NEC	12.2	Toshiba	11.0	Samsung	19.7	Samsung	32.3	Samsung	8.8
3	Hitachi	3.9	Toshiba	10.6	NEC	10.9	TI	13.7	Qualcomm**	13.2	Qualcomm**	4.2
4	Intel	3.7	Hitachi	9.8	Samsung	10.6	Toshiba	10.0	п	12.1	Micron	4.2
5	Motorola	3.0	Motorola	8.6	TI	9.6	ST	9.9	Toshiba	11.2	SK Hynix	3.5
6	Fujitsu	2.8	Samsung	8.4	Motorola	7.9	Renesas	8.2	Renesas	9.3	Toshiba	2.8
7	Mitsubishi	2.6	TI	7.9	ST	7.9	Hynix	7.4	SK Hynix	9.1	TI	2.8
8	TI	2.5	IBM	5.7	Hitachi	7.4	Freescale	6.1	ST	8.4	Broadcom**	2.0
9	Philips	1.9	Mitsubishi	5.1	Infineon	6.8	NXP	5.9	Micron	8.0	Renesas	1.9
10	Matsushita	1.8	Hyundai	4.4	Philips	6.3	NEC	5.7	Broadcom**	7.8	ST	1.8
Top 10 To	otal (\$B)	31.8		86.3		108.1		118.2		160.5		43.6
Semi Mar	rket (\$B)	54.3		154		218.6		265.5		313.3		82.7
Top 10 %	of Total Semi	59%		56%		49%		45%		51%		53%

Source: IC Insights

*Not including foundries

**Fabless

1st Annual SWTW 1990



Semiconductor Industry Growth since 1990 is ~7.1% per year

SW Test has seen attendance as high as 675 and as low 105!



SW-Test Workshop

SW Test is a Probe Technology Forum ...

- Focused Technical Workshop for Wafer Test Professionals
- Practical solutions to real problems
- Balanced mixture of semiconductor manufacturer, and supplier as well as collaborative presentations

Informal Conference ...

J. Broz

- Friendly workshop format focused on technical exchange
- Great social activities to facilitate networking and informal discussions
- Meet new people, talk about probe and technology, and have some fun!

• SW Test pursues a "Green Initiative" ...

Downloadable eProceedings and enviro-friendly practices

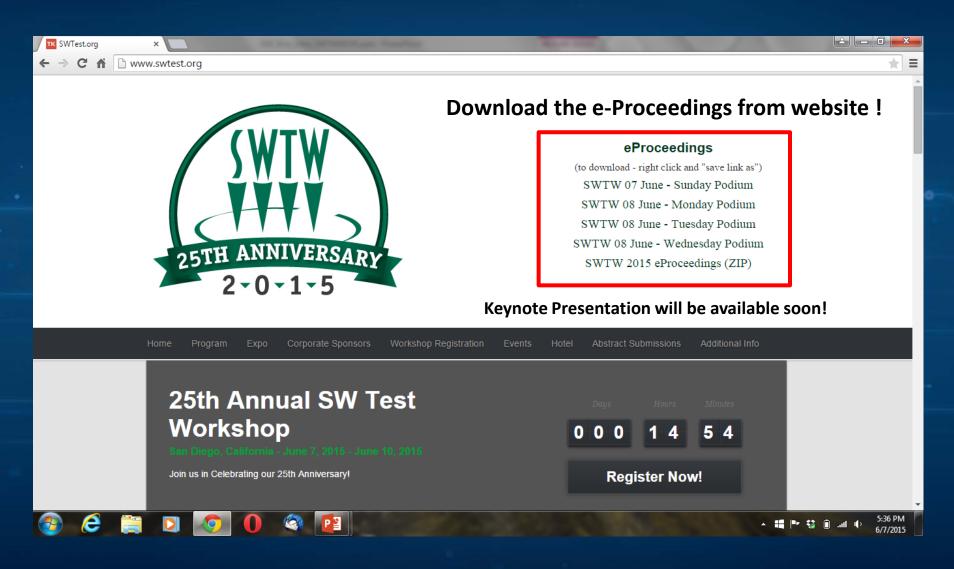
SW Test 2015 e-Proceedings?



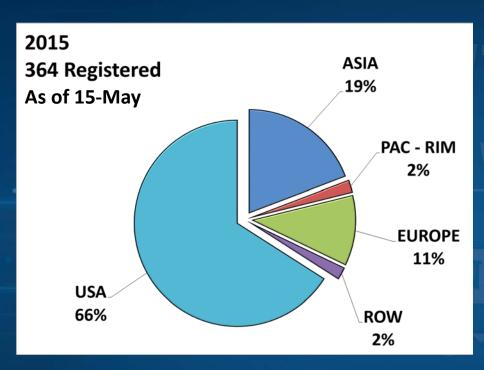
Password for Sunday = sandiego Password for Monday = longmont

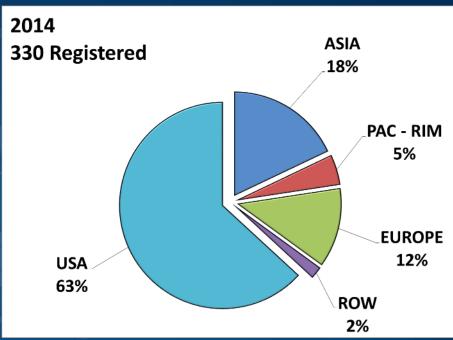
- SW Test Team continues to be focused on a green initiative.
- Each day of the workshop will be available for download in a password protected file.
 - http://www.swtest.org
 WiFi Password = aragon2015
- WiFi will be available during the entire workshop to allow access to website for download.
- The daily PDF file password will be announced through the day.

SW Test 2015 e-Proceedings?



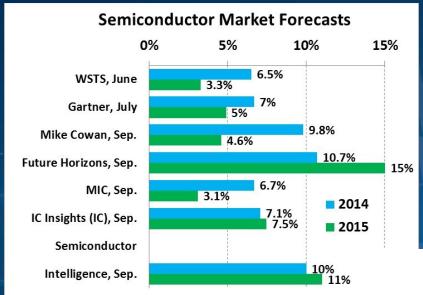
Attendance in 2015 is Strong!





15 out of 32 Podium Presentations have international authorship!

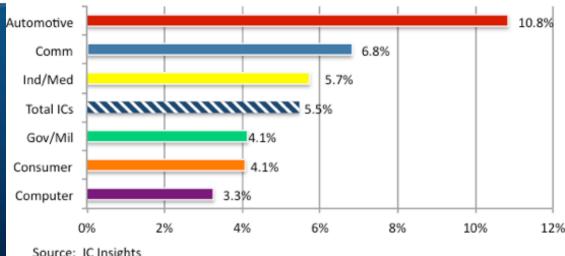
Projected IC Growth by Application



WSTS predicts

- 3.4% growth for 2015 (\$344.5 billion)
- 3.1% growth for 2016 (\$355.3 billion)

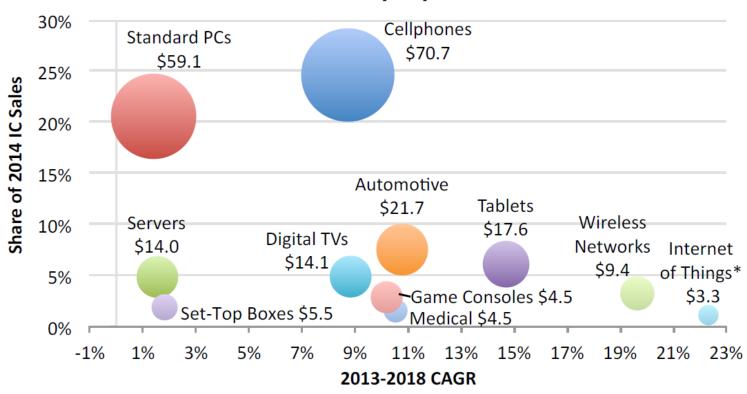




Source: IC Insights

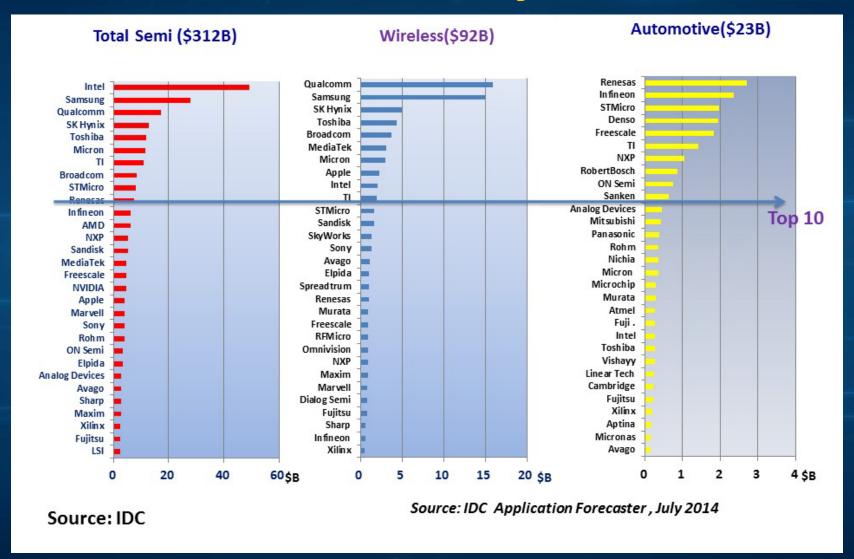
Market Sizes and Growth Rates

IC End-Use Markets (\$B) and Growth Rates

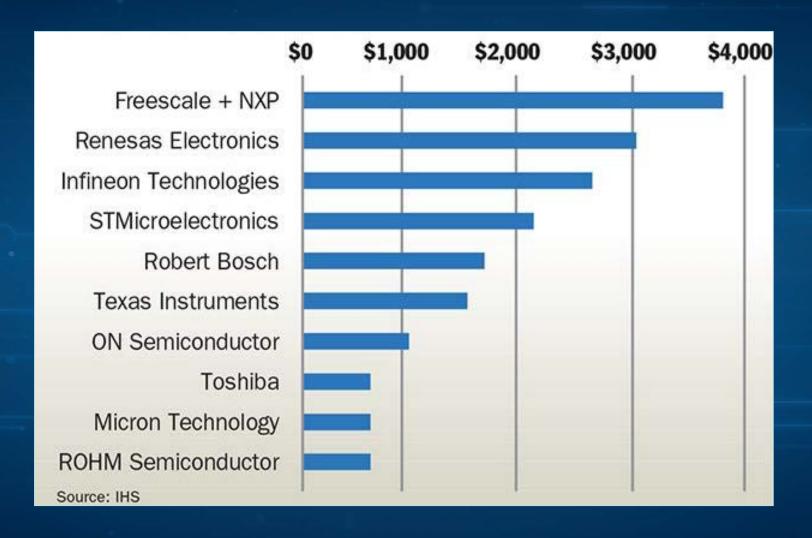


*Covers only the Internet connection portion of systems
Source: IC Insights

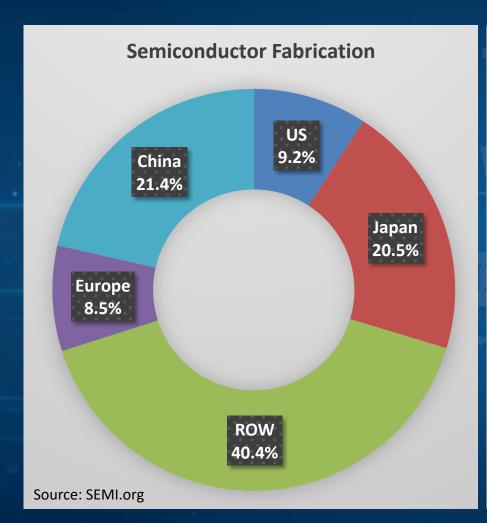
Market Players

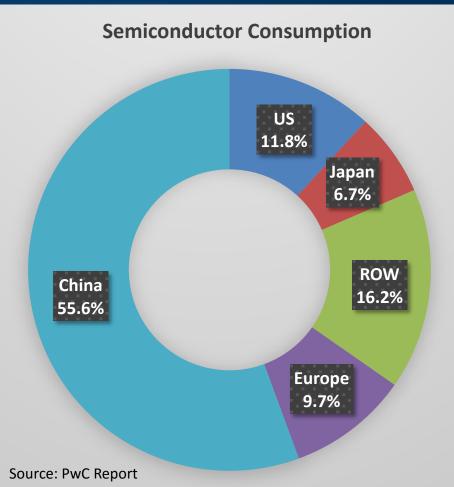


Freescale + NXP = Largest Supplier of Automotive IC



Worldwide IC





Industry Snapshot from 1998

Rank 1998	Rank 1997	Company	Country of origin	Revenue (million \$ USD)
1	1	Intel Corporation	USA	22 784
2	2	NEC Semiconductors	Japan	8 135
3	3	Motorola Semiconductors	USA	7 086
4	5	Toshiba Semiconductor	Japan	5 869
5	4	Texas Instruments	USA	5 820
6	6	Hitachi Semiconductors	Japan	4 620
7	7	Samsung Semiconductors	South Korea	4 595
8	8	Philips Semiconductors	Netherlands	4 445
9	10	STMicroelectronics (1)	France I Italy	4 197
10	9	Fujitsu Semiconductors	Japan	3 826
Other				
Total F	134 800			

Top Vendors Ranking in 1998						
	PC Market = \$359M					
1	Cerprobe					
2	Japan Micronics Corp. (MJC)					
3	JEM: Japan Electonic Materials					
4	Tokyo Cathode Laboratories Inc					
5	Wentworth Laboratories					
6	FormFactor					
7	Probe Technology					
8	Cascade Microtech					
9	ESJ					
10	Upsys					
11	Microprobe					
12	SV Probe, Inc					
13	Tokyo Electron Limited (TEL)					
14	Hugle Electronics					
15	UPC					

Thanks to John West, VLSI Research

Industry Snapshot for 2014

1Q15 Top 20 Semiconductor Sales Leaders (\$M, Including Foundries)

1Q15 Rank	2014 Rank	Company	Headquarters	2014 Tot Semi	1Q14 Tot Semi	1Q15 Tot Semi	1Q15/1Q14 % Change
1	1	Intel	U.S.	51,400	11,666	11,632	0%
2	2	Samsung	South Korea	37,810	8,797	9,336	6%
3	3	TSMC*	Taiwan	24,976	4,852	6,995	44%
4	4	Qualcomm**	U.S.	19,291	4,243	4,434	5%
5	6	SK Hynix	South Korea	16,286	3,507	4,380	25%
6	5	Micron	U.S.	16,720	4,017	4,070	1%
7	7	TI	U.S.	12,167	2,791	2,939	5%
8	8	Toshiba	Japan	11,040	2,793	2,750	-2%
9	9	Broadcom**	U.S.	8,428	1,984	2,058	4%
10	12	MediaTek**	Taiwan	7,032	1,608	1,799	12%
11	10	ST	Europe	7,384	1,820	1,700	-7%
12	13	Infineon	Europe	5,938	1,440	1,672	16%
13	15	Avago**	Singapore	5,644	1,305	1,615	24%
14	11	Renesas	Japan	7,307	1,865	1,470	-21%
15	14	NXP	Europe	5,647	1,246	1,467	18%
16	17	Sony	Japan	5,292	1,011	1,272	26%
17	20	GlobalFoundries*	U.S.	4,355	980	1,190	21%
18	18	Freescale	U.S.	4,548	1,093	1,169	7%
19	23	Sharp	Japan	3,515	700	1,137	62%
20	21	UMC*	Taiwan	4,350	1,006	1,133	13%
_	_	Top 20 Total	_	259,130	58,724	64,218	9%

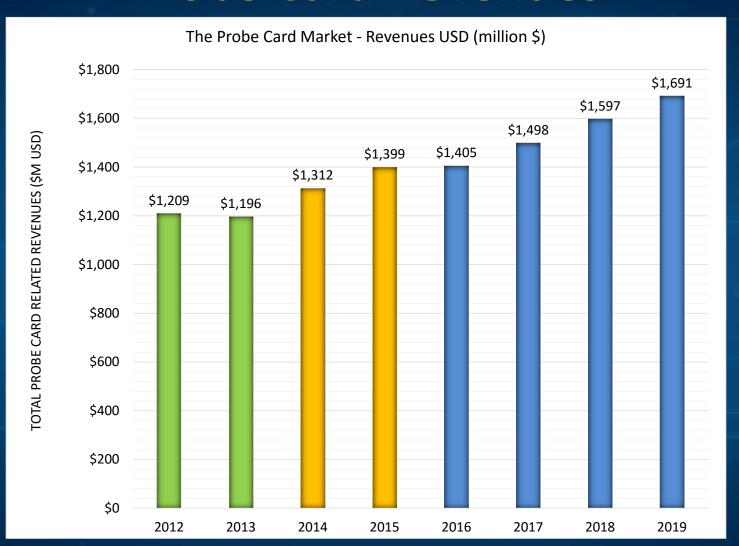
*Foundry

**Fabless

***6% growth excluding the foundries

Source: Company reports, IC Insights' Strategic Reviews database

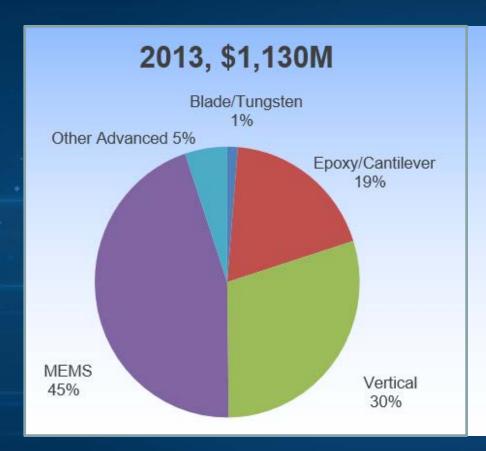
Probe Card Revenues

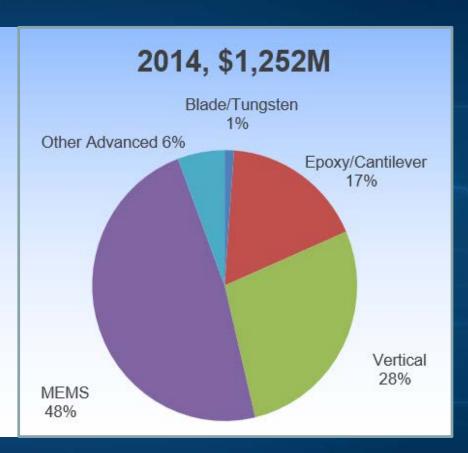


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Thanks to John West and Risto Puhakka!

Revenue by Technology





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Top Probe Card Vendors

Top 10 Semiconductor Probe Card Vendors 2014

Revenues in \$M, Calendar Year (excludes service and spares)

Rank

2014	2013	3 Company	2013	2014	% Change
1	(1)	FormFactor, Inc.	232	269	16%
2	(2)	Micronics Japan Co., Ltd.	195	220	13%
3	(3)	Technoprobe	100	105	5%
4	(4)	Japan Electronic Materials	82	95	16%
5	(5)	MPI Corporation	64	83	30%
6	(9)	Korea Instrument (KI)	37	56	51%
7	(8)	Cascade Microtech	41	52	27%
8	(7)	Microfriend	45	51	13%
9	(10)	SV TCL	33	43	30%
10	(6)	Will Technology	47	36	-23%
		Other	253.9	241.7	-5%
		Semiconductor Probe Cards	1129.9	1251.7	11%

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25th Annual SW Test Workshop

Technical Program for 2015

- Technical Tutorial on Sunday
- Nine Focused Technical Sessions across three days
- 32 Podium Presentations and a Panel Discussion

Products / Services EXPO

- 42 full size booths ... SOLD OUT!
- EXPO does not compete with Technical Program
- Corporate Support Program ... MANY THANKS!

Platinum Supporters

PLATINUM SPONSOR









PLATINUM SPONSOR



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Gold and Silver Supporters

Gold Sponsors









Silver Sponsors











"We're not in it for the money ..."

 SW Test Team has worked closely with the RBI staff such that every attendee has free parking, in-room internet, no resort fees, WiFi access during the workshop, and the best on-site conference room rate.

SW Test Executive Team ...

- Jerry Broz, Ph.D., General Chair and Sr. Member IEEE
- Rey Rincon, Freescale Semiconductor, Technical Program Chair
- Maddie Harwood, CEM Inc., Finance Chair
- Meredith Griffith, CEM Inc., EXPO / Registration Coordinator

"Who's Really to Blame ..."

Program Committee ...

- John Caldwell (Micron Technology)
- Darren James (Rudolph Technologies)
- Gary Maier (IBM)
- Patrick Mui (JEM America)

Steering Committee ...

- Gunther Boehm (FeinMetall GmbH)
- Michael Huebner, Ph.D. (FormFactor)
- Amy Leong (Formfactor)
- Clark Liu (PTI)
- Mark Ojeda (Spansion)
- Fred Taber (Taber Consulting)
- Joey Wu (MPI)
- Karen Armendariz (Celadon Systems)
- Stevan Hunter, Ph.D. (ON Semi / BYU Idaho)

June 7-10, 2015

Al Wegleitner (Texas Instruments)

SW Test is organized, coordinated, and executed through the efforts of your colleagues.

New Member ...

Sang Kyu (SK) Yoo(Samsung Electronics – Korea)

Technical Program / Agenda

Sunday, June 8

- Tutorial Sessions
 - Understanding RF measurements using advanced cantilever technologies
 - Paul O'Neil MSc MIET (aps Solutions GmbH)
 - Reduce wafer test with 3% to 10%+ by optimizing touchdown patterns
 - André Stoelwinder (OrangGO)
- Registration and Cocktails
- Buffet Dinner and Keynote Presentation

Keynote Speaker

Sunday, June 8

David McCann

Vice President of Packaging R+D and Operations





The trends, challenges, and directions for silicon beyond 28nm

Technical Program / Agenda

Monday, June 8

- Registration and Breakfast
- Vertically Challenged
- Lasers and Sensors
 - Lunch (Aragon Lawn)
- High Speed Testing Challenges and Innovations
- Technical Panel Discussions
- SW Test EXPO 2015 w/ Dinner at Reception Stations
 - Networking at La-Taberna Bar
 - Hospitality Suites for even more networking

32

Rancho Bernardo 2015





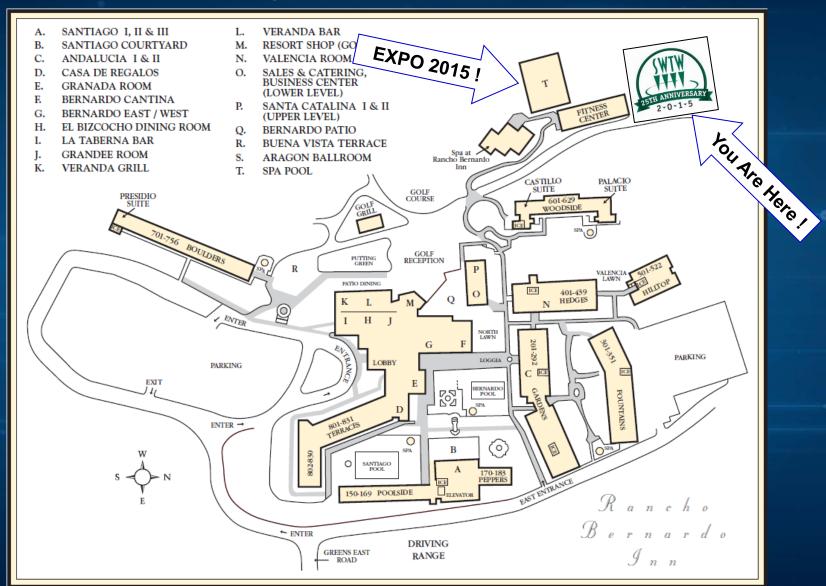
SW Test 2016
June 5 to 8, 2016
Rancho Bernardo Inn
San Diego, CA







Map of the Area

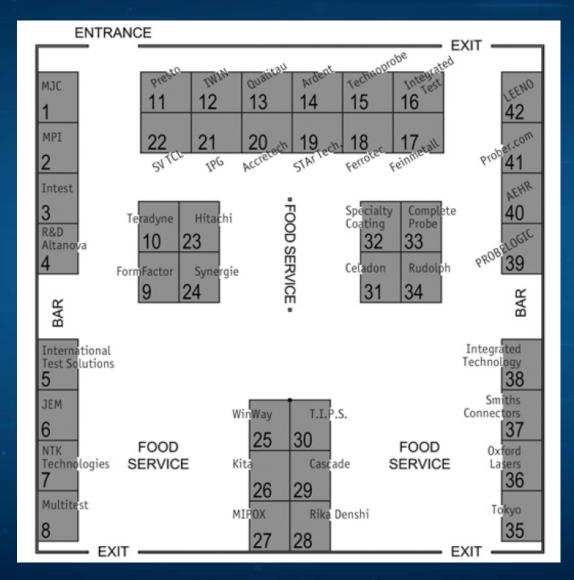


SW Test EXPO 2015

- AEHR TEST SYSTEMS
- Ardent Concepts
- Cascade Microtech, Inc.
- Celadon Systems
- Complete Probe Solutions Inc.
- Feinmetal GmbH
- Ferrotec (USA) Corp.
- FormFactor, Inc. ... PLATINUM
- Hitachi Chemical Co, Ltd.
- Integrated Technology Corporation
- Integrated Test Corporation ... SILVER
- International Test Solutions, Inc ... PLATINUM
- Intest Corporation
- IPG Photonics, Microsystems Division
- IWIN Co.,Ltd.
- JEM America Corp. ... PLATINUM
- Kita USA Inc
- LEENO Industrial Inc.
- MIPOX International Corporation
- Micronics Japan Co., LTD. ... PLATINUM
- MPI Corporation ... PLATINUM

- NTK Technologies
- Oxford Lasers
- Presto Engineering
- PROBELOGIC, INC.
- Prober.com
- QualiTau Inc.
- R & D Altanova ... PLATINUM
- Rika Denshi America, Inc.
- Rudolph Technologies
- Smiths Connectors
- Specialty Coating Systems
- STAr Technologies, Inc.
- SV TCL SV Probe ... GOLD
- Synergie CAD Probe ... GOLD
- T.I.P.S. Messtechnik GmbH ... GOLD
- TechnoProbe America ... GOLD
- Teradyne GSO ... PLATINUM
- Teradyne
- Tokyo Electron Laboratory
- WinWay Technology ... PLATINUM
- Xcerra ... SILVER

SW Test EXPO 2015



QR Code on Badges

- QR codes on the backside of the badges
 - First and Last Name
 - Organization
 - Email Address
- Suggested Free Readers
 - QRReader (TapMedia)
 - ScanLife (Scanbuy)
 - Many more free Apps are available



Download App and Test before entering the EXPO

Technical Program / Agenda

Tuesday, June 9

- Registration and Continental Breakfast
- Probe Card Analytics
- Probe Potpourri
 - Lunch (Aragon Lawn)
- Here is Something Different
- EXPO 2015 w/ Refreshments will be served
- Hawaiian Feast and Islanders Luau Show

Tuesday Social Celebrates 25th Anniversary of SW Test

- 6:00 PM Welcome greeting by hula dancers around the RBI Spa Pool
- 6:45 PM Conch shell call and drums signal dinner on the Golf Course.
 Cash Bar available throughout the evening
- 8:15 PM Islanders Luau Show
- Kids <u>under 12</u> can join for free!





Technical Program / Agenda

- Wednesday, June 10
 - Registration
 - Probe Efficiency Improvements
 - High Volume Probe Challenges
 - Awards and Adjournment
 - Box Lunch (Aragon Lawn)

Recognition & Awards

- Most "Inspirational" Presentation
- Best Presentation, Tutorial in Nature
- Best Data Presented
- Best Overall Presentation

Some other "Special Awards"

SWTW-2014 Awards

Most Inspirational Presentation

"Transferable Fine-Pitch Probes"

Dr. Steven Wright, Yang Liu, and Bing Dang (IBM TJ Watson Center)

"Transverse Load Analysis for Semiconductor Applications"

Soheil Khavandi, Jerry Broz (International Test Solutions)

Parker Fellows, Aaron Lomas, Robert Hartley, and Jordan James (University of Nevada, Reno)



Best Presentation, Tutorial in Nature

"Fusion Cuisine" - Hybrid technologies to address MEMS sensors, magnetics and high voltage probing

Dr. Rainer Gaggl and Georg Franz (T.I.P.S. Messtechnik GmbH)



SWTW-2014 Awards

Best Data Presentation

"Low Temperature Test: A low cost design and test methodology to streamline package testing for Automotive IC requirements"

Daniel Fresquez (Texas Instruments – Dallas)



Best Overall Presentation

Probing Study of 80um Grid-array Cu Pillars

Amy Leong (FormFactor)

Alexander Wittig (Globalfoundries, Germany)

Tin Nguyen and Tommaso Masi (FormFactor)



That "Special" Award ...



Bill Mann's Poorest Disguised Sales Pitch

"What happens at SW Test stays at SW Test !!"

Want to Learn More?

- 61st IEEE Holm Conference on Electrical Contacts
 October 11 to 14, 2015, in San Diego, CA
 http://www.ieee-holm.org
- 17th Electronics Packaging Technology Conference December 2 to 4t, 2015, in San Diego, CA http://www.eptc-ieee.net
- Burn In & Test Strategies Workshop March 6 to 9, 2016 in Mesa, Arizona http://www.bitsworkshop.org
- IS-Test Workshop
 May, 2016 in Freising, Germany
 http://www.is-test.com
- 66th Electronic Components and Technology Conference May 28 to June 5, 2016, in Las Vegas, NV, USA http://www.ectc.net
- ProbeCard Insider
 Technology Blog by Paul Meyer focused on Probe Cards http://probecardinsider.com





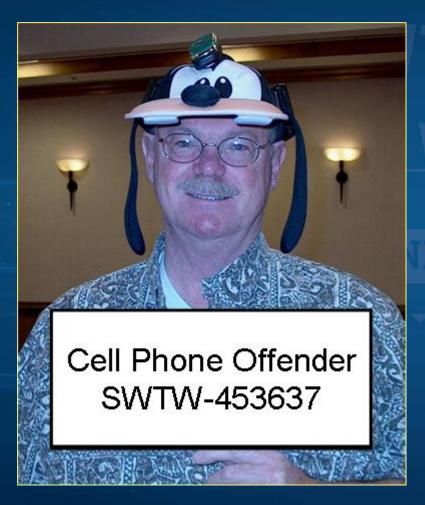








Silence your cell phone !!!





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Thanks for your Support!

Contact the SW Test Team with any questions ...

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